

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/589,826 DE LUCA ET AL.	
		Examiner	Art Unit ALEX W. MOK	2834      Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0190592 A1	12-2002	Kawasaki, Shuichi	310/90.5
*	B	US-2002/0074883 A1	06-2002	Yamauchi et al.	310/90.5
*	C	US-4,999,534 A	03-1991	Andrianos, Nikos P.	310/90.5
*	D	US-4,339,780 A	07-1982	Okubo, Shigeo	361/147
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.